

128Mb K-die SDRAM Specification

54 TSOP-II
with Lead-Free & Halogen-Free
(RoHS compliant)

勝特力材料 886-3-5753170
勝特力电子(上海) 86-21-34970699
勝特力电子(深圳) 86-755-83298787
[Http://www.100y.com.tw](http://www.100y.com.tw)

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Revision History

Revision	Month	Year	History
1.0	February	2007	- Release revision 1.0 SPEC
1.1	November	2007	- Revised typo of package dimension - Added the comment of Halogen-Free supporting
1.2	February	2008	- Added -50 bin(200MHz) DRAM
1.21	March	2008	- Added Package pin out lead width
1.22	August	2008	- Corrected typo and font format
1.23	March	2009	- Deleted organization x4

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4M x 8Bit x 4 Banks / 2M x 16Bit x 4 Banks SDRAM

1.0 Features

- JEDEC standard 3.3V power supply
- LVTTTL compatible with multiplexed address
- Four banks operation
- MRS cycle with address key programs
 - CAS latency (2 & 3)
 - Burst length (1, 2, 4, 8 & Full page)
 - Burst type (Sequential & Interleave)
- All inputs are sampled at the positive going edge of the system clock.
- Burst read single-bit write operation
- DQM (x8) & L(U)DQM (x16) for masking
- Auto & self refresh
- 64ms refresh period (4K Cycle)
- 54pin TSOP II **Lead-Free and Halogen-Free** package
- **RoHS compliant**

2.0 General Description

The K4S280832K / K4S281632K is 134,217,728 bits synchronous high data rate Dynamic RAM organized as 4 x 4,194,304 words by 8 bits / 4 x 2,097,152 words by 16 bits, fabricated with SAMSUNG's high performance CMOS technology. Synchronous design allows precise cycle control with the use of system clock I/O transactions are possible on every clock cycle. Range of operating frequencies, programmable burst length and programmable latencies allow the same device to be useful for a variety of high bandwidth, high performance memory system applications.

3.0 Ordering Information

Part No.	Organization	Max Freq.	Interface	Package
K4S280832K-U ^{*1} C/L75	16Mb x 8	133MHz (CL=3)	LVTTTL	54pin TSOP(II) Lead-Free & Halogen-Free^{*1}
K4S281632K-UC/L50	8Mb x 16	200MHz(CL=3)		
K4S281632K-UC/L60	8Mb x 16	166MHz (CL=3)		
K4S281632K-UC/L75	8Mb x 16	133MHz (CL=3)		

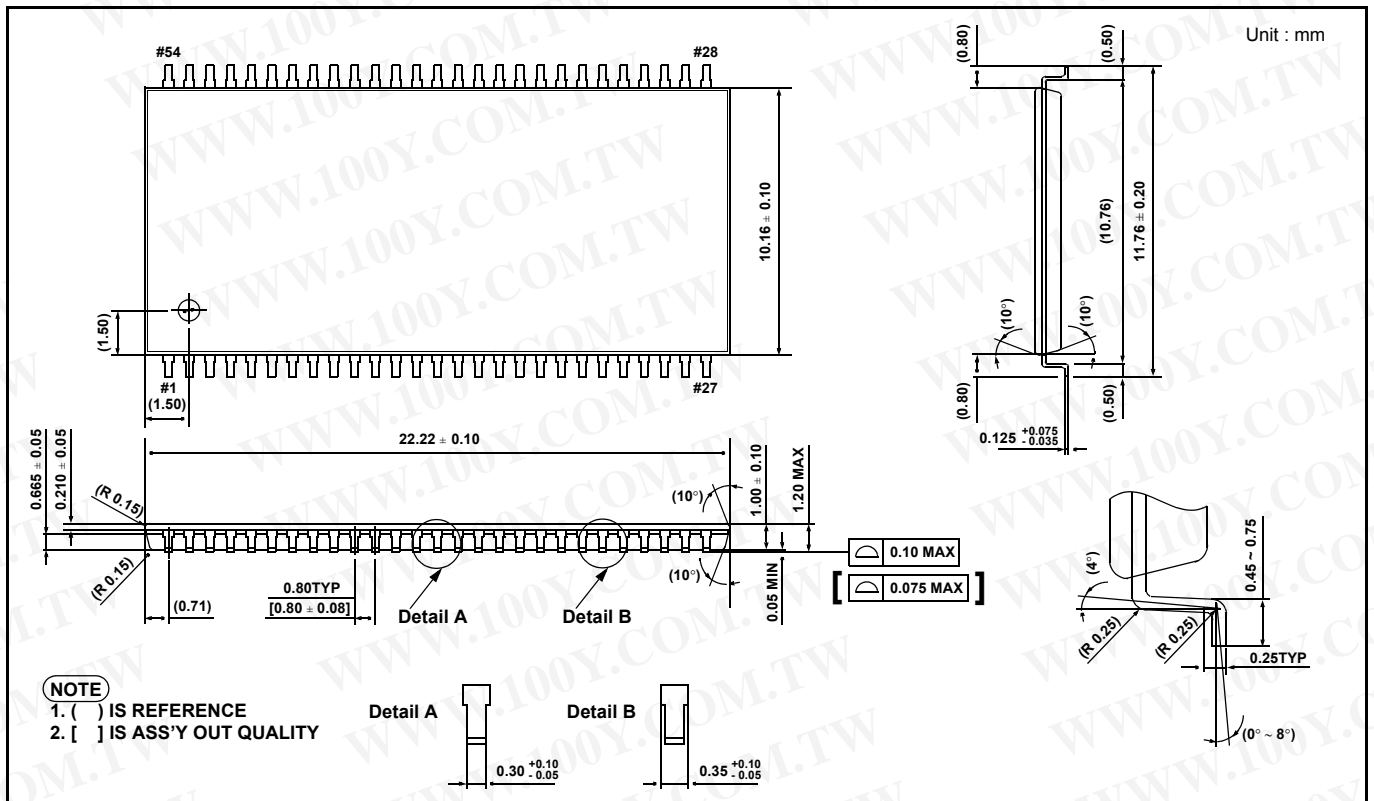
Note 1 : 128Mb K-die SDR DRAMs support Lead-Free & Halogen-Free package with Lead-Free package code(-U).

Organization	Row Address	Column Address
16Mx8	A0~A11	A0-A9
8Mx16	A0~A11	A0-A8

Row & Column address configuration

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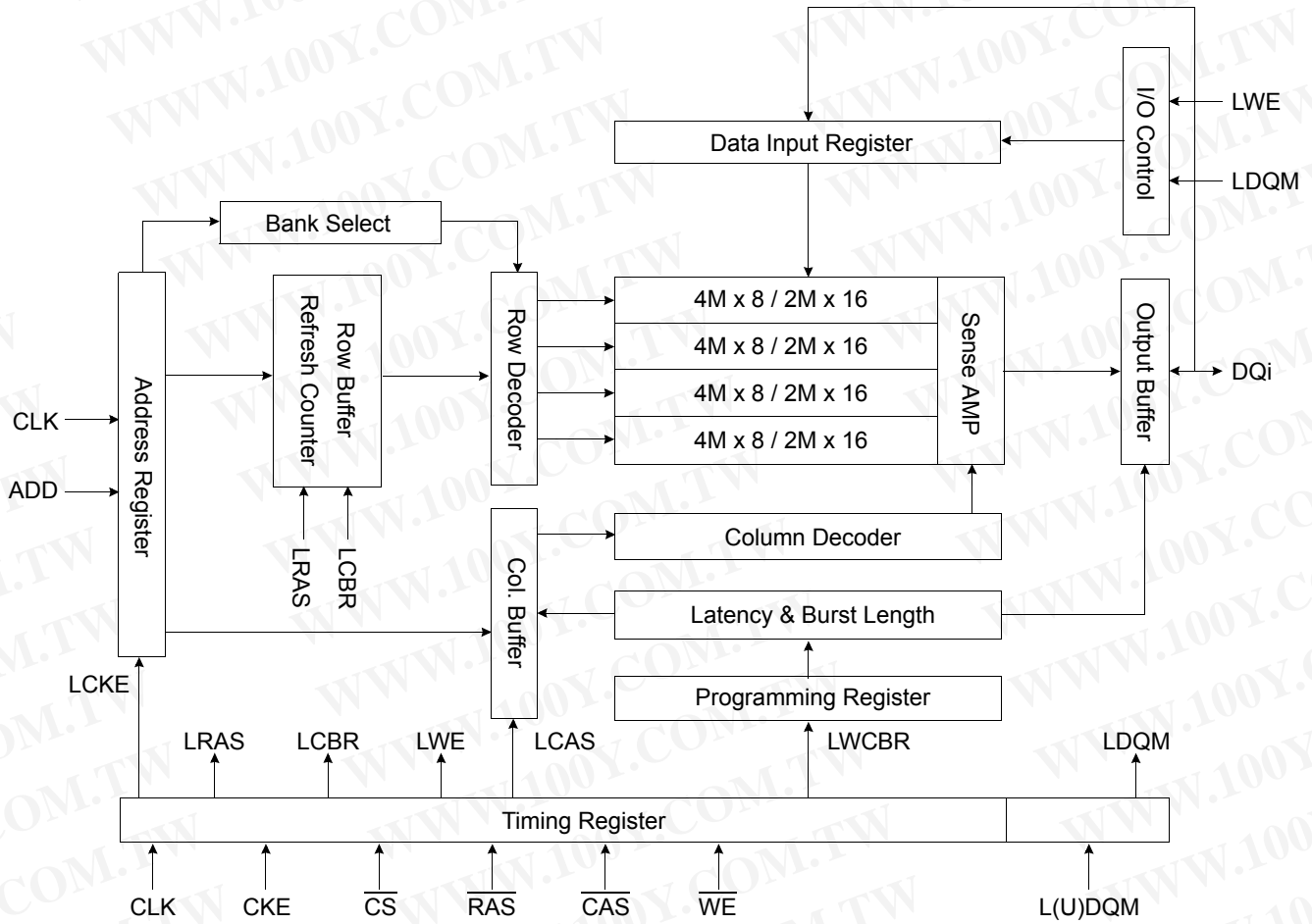
4.0 Package Physical Dimension



54Pin TSOP(II) Package Dimension

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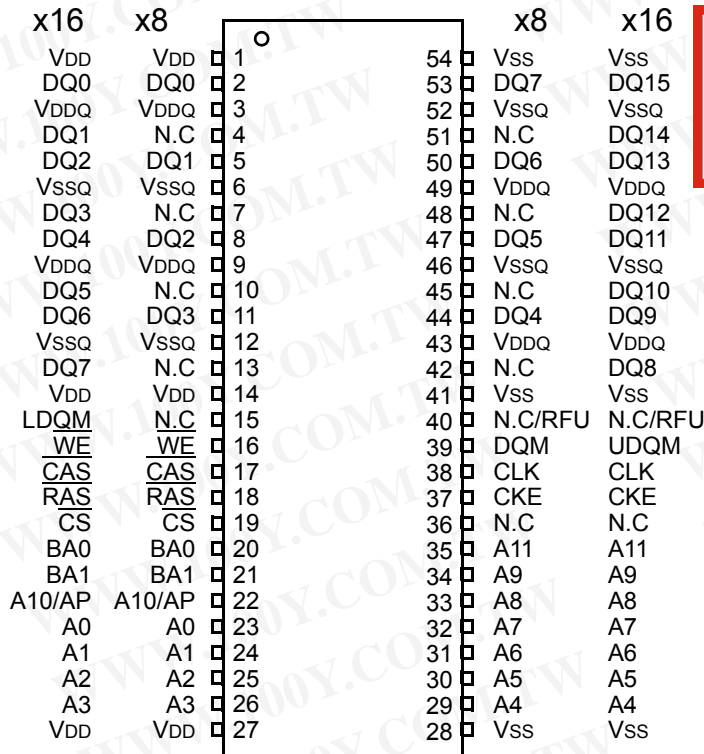
5.0 Functional Block Diagram



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6.0 Pin Configuration (Top view)



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54Pin TSOP
(400mil x 875mil)
(0.8 mm Pin pitch)

7.0 Pin Function Description

Pin	Name	Input Function
CLK	System clock	Active on the positive going edge to sample all inputs.
$\overline{\text{CS}}$	Chip select	Disables or enables device operation by masking or enabling all inputs except CLK, CKE and DQM
CKE	Clock enable	Masks system clock to freeze operation from the next clock cycle. CKE should be enabled at least one cycle prior to new command. Disable input buffers for power down in standby.
A0 ~ A11	Address	Row/column addresses are multiplexed on the same pins. Row address : RA0 ~ RA11, Column address : (x8 : CA0 ~ CA9), (x16 : CA0 ~ CA8)
BA0 ~ BA1	Bank select address	Selects bank to be activated during row address latch time. Selects bank for read/write during column address latch time.
$\overline{\text{RAS}}$	Row address strobe	Latches row addresses on the positive going edge of the CLK with $\overline{\text{RAS}}$ low. Enables row access & precharge.
$\overline{\text{CAS}}$	Column address strobe	Latches column addresses on the positive going edge of the CLK with $\overline{\text{CAS}}$ low. Enables column access.
$\overline{\text{WE}}$	Write enable	Enables write operation and row precharge. Latches data in starting from $\overline{\text{CAS}}$, $\overline{\text{WE}}$ active.
DQM	Data input/output mask	Makes data output Hi-Z, tSHZ after the clock and masks the output. Blocks data input when DQM active.
DQ0 ~ N	Data input/output	Data inputs/outputs are multiplexed on the same pins. (x8 : DQ0 ~ 7), (x16 : DQ0 ~ 15)
VDD/VSS	Power supply/ground	Power and ground for the input buffers and the core logic.
VDDQ/VSSQ	Data output power/ground	Isolated power supply and ground for the output buffers to provide improved noise immunity.
N.C/RFU	No connection /reserved for future use	This pin is recommended to be left No Connection on the device.

8.0 Absolute Maximum Ratings

Parameter	Symbol	Value	Unit
Voltage on any pin relative to V_{SS}	V_{IN}, V_{OUT}	-1.0 ~ 4.6	V
Voltage on V_{DD} supply relative to V_{SS}	V_{DD}, V_{DDQ}	-1.0 ~ 4.6	V
Storage temperature	T_{STG}	-55 ~ +150	°C
Power dissipation	P_D	1	W
Short circuit current	I_{OS}	50	mA

Note : Permanent device damage may occur if "ABSOLUTE MAXIMUM RATINGS" are exceeded.
Functional operation should be restricted to recommended operating condition.
Exposure to higher than recommended voltage for extended periods of time could affect device reliability.

9.0 DC Operating Conditions

Recommended operating conditions (Voltage referenced to $V_{SS} = 0V$, $T_A = 0$ to $70^\circ C$)

Parameter	Symbol	Min	Typ	Max	Unit	Note
Supply voltage	V_{DD}, V_{DDQ}	3.0	3.3	3.6	V	
Input logic high voltage	V_{IH}	2.0	3.0	$V_{DD}+0.3$	V	1
Input logic low voltage	V_{IL}	-0.3	0	0.8	V	2
Output logic high voltage	V_{OH}	2.4	-	-	V	$I_{OH} = -2mA$
Output logic low voltage	V_{OL}	-	-	0.4	V	$I_{OL} = 2mA$
Input leakage current	I_{LI}	-10	-	10	uA	3

Notes : 1. V_{IH} (max) = 5.6V AC. The overshoot voltage duration is $\leq 3ns$.
2. V_{IL} (min) = -2.0V AC. The undershoot voltage duration is $\leq 3ns$.
3. Any input $0V \leq V_{IN} \leq V_{DDQ}$.
Input leakage currents include Hi-Z output leakage for all bi-directional buffers with Tri-State outputs.

10.0 Capacitance

($V_{DD} = 3.3V$, $T_A = 23^\circ C$, $f = 1MHz$, $V_{REF} = 1.4V \pm 200 mV$)

Pin	Symbol	Min	Max	Unit
Clock	C_{CLK}	2.5	3.5	pF
RAS, CAS, \overline{WE} , CS, CKE, DQM	C_{IN}	2.5	3.8	pF
Address	C_{ADD}	2.5	3.8	pF
(x8 : DQ0 ~ DQ7), (x16 : DQ0 ~ DQ15)	C_{OUT}	4.0	6.0	pF

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11.0 DC Characteristics (x8)

(Recommended operating condition unless otherwise noted, $T_A = 0$ to 70°C)

Parameter	Symbol	Test Condition	Version	Unit	Note	
			75			
Operating current (One bank active)	Icc1	Burst length = 1 $t_{RC} \geq t_{RC}(\text{min})$ IO = 0 mA	90	mA	1	
Precharge standby current in power-down mode	Icc2P	$\text{CKE} \leq V_{IL}(\text{max})$, $t_{CC} = 10\text{ns}$	2	mA		
	Icc2PS	$\text{CKE} \ \& \ \text{CLK} \leq V_{IL}(\text{max})$, $t_{CC} = \infty$	2			
Precharge standby current in non power-down mode	Icc2N	$\text{CKE} \geq V_{IH}(\text{min})$, $\text{CS} \geq V_{IH}(\text{min})$, $t_{CC} = 10\text{ns}$ Input signals are changed one time during 20ns	20	mA		
	Icc2NS	$\text{CKE} \geq V_{IH}(\text{min})$, $\text{CLK} \leq V_{IL}(\text{max})$, $t_{CC} = \infty$ Input signals are stable	10			
Active standby current in power-down mode	Icc3P	$\text{CKE} \leq V_{IL}(\text{max})$, $t_{CC} = 10\text{ns}$	5	mA		
	Icc3PS	$\text{CKE} \ \& \ \text{CLK} \leq V_{IL}(\text{max})$, $t_{CC} = \infty$	5			
Active standby current in non power-down mode (One bank active)	Icc3N	$\text{CKE} \geq V_{IH}(\text{min})$, $\text{CS} \geq V_{IH}(\text{min})$, $t_{CC} = 10\text{ns}$ Input signals are changed one time during 20ns	30	mA		
	Icc3NS	$\text{CKE} \geq V_{IH}(\text{min})$, $\text{CLK} \leq V_{IL}(\text{max})$, $t_{CC} = \infty$ Input signals are stable	25			
Operating current (Burst mode)	Icc4	IO = 0 mA Page burst	110	mA	1	
Refresh current	Icc5	$t_{RC} \geq t_{RC}(\text{min})$	200	mA	2	
Self refresh current	Icc6	$\text{CKE} \leq 0.2\text{V}$	C	2	mA	3
			L	800	uA	4

- Notes :**
1. Measured with outputs open.
 2. Refresh period is 64ms.
 3. K4S280832K-UC
 4. K4S280832K-UL
 5. Unless otherwise noted, input swing level is CMOS($V_{IH}/V_{IL} = V_{DDQ}/V_{SSQ}$)

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12.0 DC Characteristics (x16)

(Recommended operating condition unless otherwise noted, TA = 0 to 70°C)

Parameter	Symbol	Test Condition	Version			Unit	Note
			50	60	75		
Operating current (One bank active)	I _{CC1}	Burst length = 1 t _{RC} ≥ t _{RC(min)} IO = 0 mA	140	130	100	mA	1
Precharge standby current in power-down mode	I _{CC2P}	CKE ≤ V _{IL(max)} , t _{CC} = 10ns	2			mA	
	I _{CC2PS}	CKE & CLK ≤ V _{IL(max)} , t _{CC} = ∞	2				
Precharge standby current in non power-down mode	I _{CC2N}	CKE ≥ V _{IH(min)} , \overline{CS} ≥ V _{IH(min)} , t _{CC} = 10ns Input signals are changed one time during 20ns	20			mA	
	I _{CC2NS}	CKE ≥ V _{IH(min)} , CLK ≤ V _{IL(max)} , t _{CC} = ∞ Input signals are stable	10				
Active standby current in power-down mode	I _{CC3P}	CKE ≤ V _{IL(max)} , t _{CC} = 10ns	5			mA	
	I _{CC3PS}	CKE & CLK ≤ V _{IL(max)} , t _{CC} = ∞	5				
Active standby current in non power-down mode (One bank active)	I _{CC3N}	CKE ≥ V _{IH(min)} , \overline{CS} ≥ V _{IH(min)} , t _{CC} = 10ns Input signals are changed one time during 20ns	30			mA	
	I _{CC3NS}	CKE ≥ V _{IH(min)} , CLK ≤ V _{IL(max)} , t _{CC} = ∞ Input signals are stable	25				
Operating current (Burst mode)	I _{CC4}	IO = 0 mA Page burst 4Banks Activated t _{CCD} = 2CLKs	160	150	140	mA	1
Refresh current	I _{CC5}	t _{RC} ≥ t _{RC(min)}	230	220	200	mA	2
Self refresh current	I _{CC6}	CKE ≤ 0.2V	C			mA	3
			L				

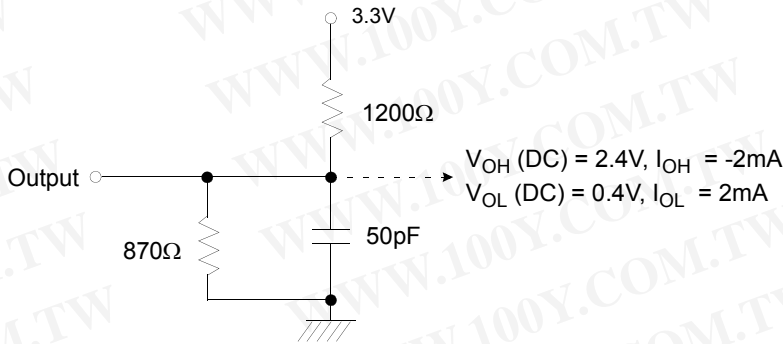
- Notes :**
1. Measured with outputs open.
 2. Refresh period is 64ms.
 3. K4S281632K-UC
 4. K4S281632K-UL
 5. Unless otherwise noted, input swing level is CMOS(V_{IH} / V_{IL} = V_{DDQ} / V_{SSQ})

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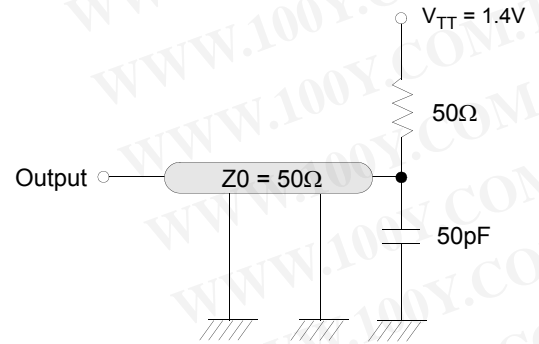
13.0 AC Operating Test Conditions

($V_{DD} = 3.3V \pm 0.3V$, $T_A = 0$ to $70^\circ C$)

Parameter	Value	Unit
Input levels (V_{IH}/V_{IL})	2.4/0.4	V
Input timing measurement reference level	1.4	V
Input rise and fall time	tr/ta = 1/1	ns
Output timing measurement reference level	1.4	V
Output load condition	See Fig. 2	



(Fig. 1) DC output load circuit



(Fig. 2) AC output load circuit

14.0 Operating AC Parameter

(AC operating conditions unless otherwise noted)

Parameter	Symbol	Version			Unit
		50 (x16 only)	60 (x16 only)	75	
Row active to row active delay	tRRD(min)	10	12	15	ns
RAS to CAS delay	tRCD(min)	15	18	20	ns
Row precharge time	tRP(min)	15	18	20	ns
Row active time	tRAS(min)	40	42	45	ns
	tRAS(max)	100			us
Row cycle time	tRC(min)	55	60	65	ns
Last data in to row precharge	tRDL(min)	2			CLK
Last data in to Active delay	tDAL(min)	2 CLK + tRP			-
Last data in to new col. address delay	tCDL(min)	1			CLK
Last data in to burst stop	tBDL(min)	1			CLK
Col. address to col. address delay	tCCD(min)	1			CLK
Number of valid output data	CAS latency=3	2			ea
	CAS latency=2	-		1	

- Notes :**
- The minimum number of clock cycles is determined by dividing the minimum time required with clock cycle time and then rounding off to the next higher integer.
 - Minimum delay is required to complete write.
 - All parts allow every cycle column address change.
 - In case of row precharge interrupt, auto precharge and read burst stop.
 - In 100MHz and below 100MHz operating conditions, tRDL=1CLK and tDAL=1CLK + 20ns is also supported. SAMSUNG recommends tRDL=2CLK and tDAL=2CLK + tRP.
 - tRC = tRFC, tRDL = tWR.

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15.0 AC Characteristics

(AC operating conditions unless otherwise noted)

Parameter		Symbol	50 (x16 only)		60 (x16 only)		75	
			Min	Max	Min	Max	Min	Max
CLK cycle time	CAS latency=3	tCC	5	1000	6	1000	7.5	1000
	CAS latency=2		-		-		10	
CLK to valid output delay	CAS latency=3	tSAC	-	4.5	-	5	-	5.4
	CAS latency=2		-	-	-	-	6	
Output data hold time	CAS latency=3	tOH	2	-	2.5	-	3	-
	CAS latency=2		-	-	-	-	3	-
CLK high pulse width		tCH	2	-	2.5	-	2.5	-
CLK low pulse width		tCL	2	-	2.5	-	2.5	-
Input setup time		tSS	1.5	-	1.5	-	1.5	-
Input hold time		tSH	1	-	1	-	0.8	-
CLK to output in Low-Z		tSLZ	1	-	1	-	1	-
CLK to output in Hi-Z	CAS latency=3	tSHZ	-	4.5	-	5	-	5.4
	CAS latency=2		-	-	-	-	6	

- Notes :**
- Parameters depend on programmed CAS latency.
 - If clock rising time is longer than 1ns, (tr/2-0.5)ns should be added to the parameter.
 - Assumed input rise and fall time (tr & tf) = 1ns.
If tr & tf is longer than 1ns, transient time compensation should be considered, i.e., [(tr + tf)/2-1]ns should be added to the parameter.
 - tSS applies for address setup time, clock enable setup time, command setup time and data setup time
tSH applies for address hold time, clock enable hold time, command hold time and data hold time

16.0 DQ Buffer Output Drive Characteristics

Parameter	Symbol	Condition	Min	Typ	Max	Unit	Notes
Output rise time	trh	Measure in linear region : 1.2V ~ 1.8V	1.37		4.37	Volts/ns	3
Output fall time	tfh	Measure in linear region : 1.2V ~ 1.8V	1.30		3.8	Volts/ns	3
Output rise time	trh	Measure in linear region : 1.2V ~ 1.8V	2.8	3.9	5.6	Volts/ns	1,2
Output fall time	tfh	Measure in linear region : 1.2V ~ 1.8V	2.0	2.9	5.0	Volts/ns	1,2

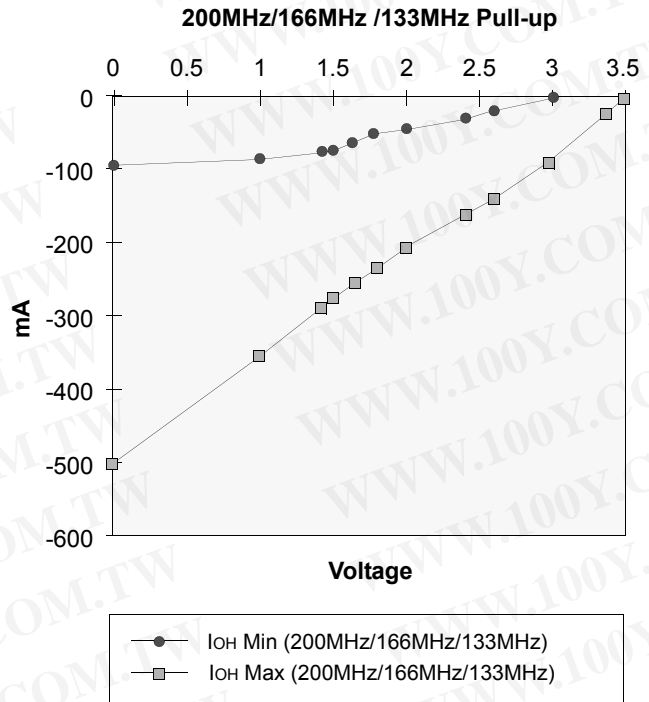
- Notes :**
- Rise time specification based on 0pF + 50 Ω to V_{SS}, use these values to design to.
 - Fall time specification based on 0pF + 50 Ω to V_{DD}, use these values to design to.
 - Measured into 50pF only, use these values to characterize to.
 - All measurements done with respect to V_{SS}.

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17.0 IBIS Specification

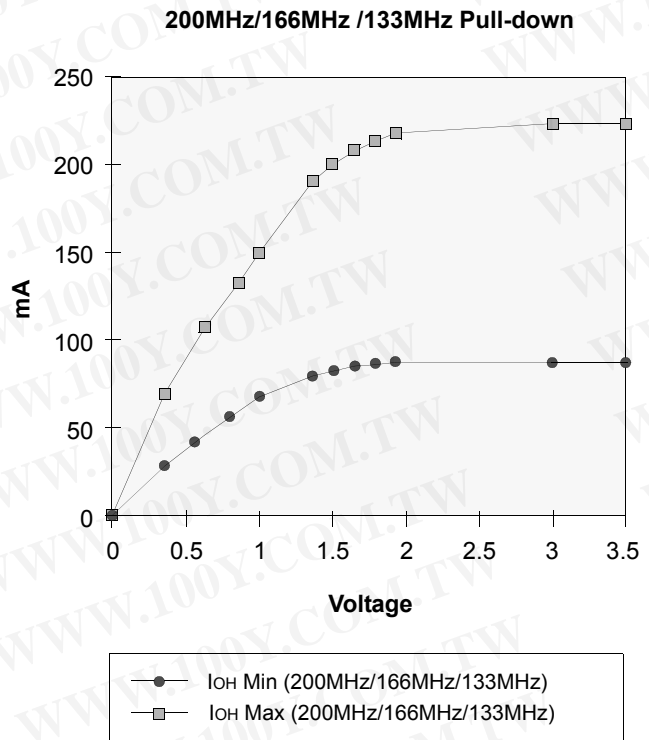
IOH Characteristics (Pull-up)

Voltage (V)	200MHz 166MHz 133MHz Min	200MHz 166MHz 133MHz Max
	I (mA)	I (mA)
3.45		-2.4
3.3		-27.3
3.0	0.0	-74.1
2.6	-21.1	-129.2
2.4	-34.1	-153.3
2.0	-58.7	-197.0
1.8	-67.3	-226.2
1.65	-73.0	-248.0
1.5	-77.9	-269.7
1.4	-80.8	-284.3
1.0	-88.6	-344.5
0.0	-93.0	-502.4



IOI Characteristics (Pull-down)

Voltage (V)	200MHz 166MHz 133MHz Min	200MHz 166MHz 133MHz Max
	I (mA)	I (mA)
0.0	0.0	0.0
0.4	27.5	70.2
0.65	41.8	107.5
0.85	51.6	133.8
1.0	58.0	151.2
1.4	70.7	187.7
1.5	72.9	194.4
1.65	75.4	202.5
1.8	77.0	208.6
1.95	77.6	212.0
3.0	80.3	219.6
3.45	81.4	222.6

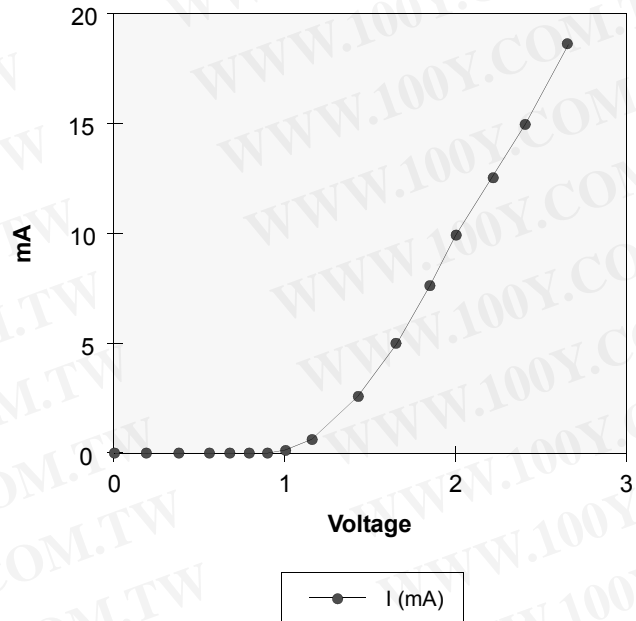


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VDD Clamp @ CLK, CKE, CS, DQM & DQ

VDD (V)	I (mA)
0.0	0.0
0.2	0.0
0.4	0.0
0.6	0.0
0.7	0.0
0.8	0.0
0.9	0.0
1.0	0.23
1.2	1.34
1.4	3.02
1.6	5.06
1.8	7.35
2.0	9.83
2.2	12.48
2.4	15.30
2.6	18.31

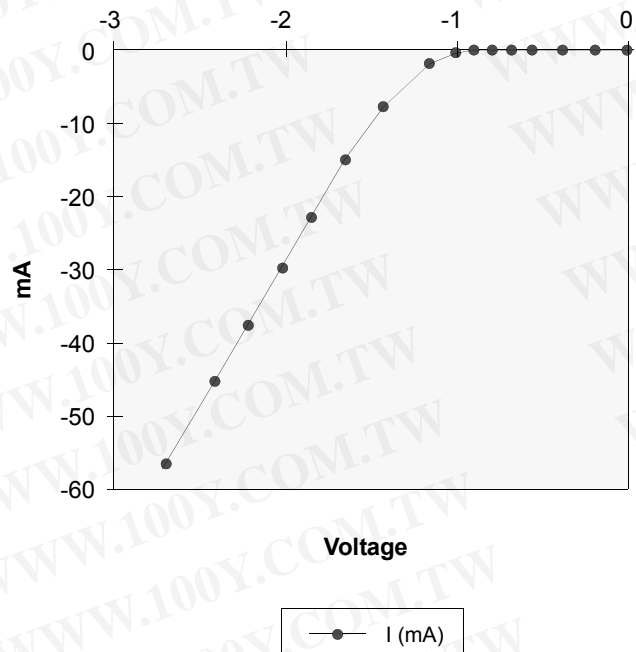
Minimum VDD clamp current
(Referenced to VDD)



VSS Clamp @ CLK, CKE, CS, DQM & DQ

VSS (V)	I (mA)
-2.6	-57.23
-2.4	-45.77
-2.2	-38.26
-2.0	-31.22
-1.8	-24.58
-1.6	-18.37
-1.4	-12.56
-1.2	-7.57
-1.0	-3.37
-0.9	-1.75
-0.8	-0.58
-0.7	-0.05
-0.6	0.0
-0.4	0.0
-0.2	0.0
0.0	0.0

Minimum VSS clamp current



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18.0 Simplified Truth Table

(V=Valid, X=Don't care, H=Logic high, L=Logic low)

Command		CKEn-1	CKEn	\overline{CS}	\overline{RAS}	\overline{CAS}	\overline{WE}	DQM	BA0,1	A10/AP	A0 ~ A9, A11,	Note
Register	Mode register set	H	X	L	L	L	L	X	OP code			1,2
Refresh	Auto refresh	H	H	L	L	L	H	X	X			3
	Self refresh	Entry	L	L	L	L	H	X	X			3
			Exit	L	H	L	H	H	H	X	X	
				L	H	X	X	X	X	X		
Bank active & row addr.		H	X	L	L	H	H	X	V	Row address		
Read & column address	Auto precharge disable	H	X	L	H	L	H	X	V	L	Column address	4
	Auto precharge enable									H		
Write & column address	Auto precharge disable	H	X	L	H	L	L	X	V	L	Column address	4
	Auto precharge enable									H		
Burst stop		H	X	L	H	H	L	X	X			6
Precharge	Bank selection	H	X	L	L	H	L	X	V	L	X	
	All banks								X	H		
Clock suspend or active power down	Entry	H	L	H	X	X	X	X	X			
				L	V	V	V	X				
	Exit	L	H	X	X	X	X	X	X			
Precharge power down mode	Entry	H	L	H	X	X	X	X	X			
				L	H	H	H	H	X			
	Exit	L	H	H	X	X	X	X	X			
				L	V	V	V	X				
DQM		H			X			V	X			7
No operation command		H	X	H	X	X	X	X	X			
				L	H	H	H	X	X			

Notes : 1. OP Code : Operand code

A0 ~ A11 & BA0 ~ BA1 : Program keys. (@ MRS)

2. MRS can be issued only at all banks precharge state.

A new command can be issued after 2 CLK cycles of MRS.

3. Auto refresh functions are as same as CBR refresh of DRAM.

The automatical precharge without row precharge command is meant by "Auto".

Auto/self refresh can be issued only at all banks precharge state.

4. BA0 ~ BA1 : Bank select addresses.

If both BA0 and BA1 are "Low" at read, write, row active and precharge, bank A is selected.

If BA0 is "High" and BA1 is "Low" at read, write, row active and precharge, bank B is selected.

If BA0 is "Low" and BA1 is "High" at read, write, row active and precharge, bank C is selected.

If both BA0 and BA1 are "High" at read, write, row active and precharge, bank D is selected.

If A10/AP is "High" at row precharge, BA0 and BA1 is ignored and all banks are selected.

5. During burst read or write with auto precharge, new read/write command can not be issued.

Another bank read/write command can be issued after the end of burst.

New row active of the associated bank can be issued at tRP after the end of burst.

6. Burst stop command is valid at every burst length.

7. DQM sampled at positive going edge of a CLK and masks the data-in at the very CLK (Write DQM latency is 0), but makes Hi-Z state the data-out of 2 CLK cycles after. (Read DQM latency is 2)

勝特力材料 886-3-5753170
勝特力电子(上海) 86-21-34970699
勝特力电子(深圳) 86-755-83298787
[Http://www.100y.com.tw](http://www.100y.com.tw)